

Notice of References Cited

Application/Contr.

09/834,954

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2826

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-4,495,512 ✓	01-1985	Isaac et al.	357/34
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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